

## **Quarterly Reliability Monitoring Results**

## Quarters: Q1/2022 to Q4/2023

Based on structural similarity

| <b>Supplier</b><br>Nexperia B.V.                                      |                             | User Part Number                                          |                       |           |            |           |  |  |
|-----------------------------------------------------------------------|-----------------------------|-----------------------------------------------------------|-----------------------|-----------|------------|-----------|--|--|
|                                                                       |                             | BC857BSH-Q                                                |                       |           |            |           |  |  |
| Name of Laboratory  Assembly reliability labs  Based on AEC-Q101 Test |                             | Part Description                                          |                       |           |            |           |  |  |
|                                                                       |                             | Nexperia DHAM Small Signal Bipolar Transistor             |                       |           |            |           |  |  |
|                                                                       |                             | SMD package                                               |                       |           |            |           |  |  |
|                                                                       |                             | Test Conditions                                           | Duration              | # Lots    | # Quantity | # Rejects |  |  |
|                                                                       | TEST                        |                                                           |                       |           |            |           |  |  |
|                                                                       | Pre- and Post-Stress        |                                                           |                       |           |            |           |  |  |
| # E1                                                                  | Electrical Test             | Tamb = 25 °C                                              | N/A                   | see below | all parts  | see below |  |  |
|                                                                       |                             | JESD22-A113                                               |                       |           |            |           |  |  |
|                                                                       | <b>DC</b>                   | Bake Tamb = 125 °C                                        | 24 hours              |           |            |           |  |  |
| <b>4</b> A 1                                                          | PC<br>Preconditioning       | Soak Tamb = 85 °C, RH = 85%<br>Reflow soldering           | 168 hours<br>3 cycles | 1674      | 70400      | 0         |  |  |
| # A1                                                                  | Freconditioning             | <u>-</u>                                                  | 3 Cycles              | 1674      | 70490      | 0         |  |  |
|                                                                       |                             | MIL-STD-750-1                                             |                       |           |            |           |  |  |
|                                                                       | HTRB                        | M1039 Method A<br>Tj = Tjmax, Vr = 100% of max. datasheet |                       |           |            |           |  |  |
| # D1                                                                  | Bias                        | reverse voltage                                           | 1000 have             | 415       | 10000      | 0         |  |  |
| # B1                                                                  | Dias                        | reverse voicage                                           | 1000 hours            | 415       | 18680      | 0         |  |  |
|                                                                       | TC                          | JESD22-A104                                               |                       |           |            |           |  |  |
| # A4                                                                  | Temperature Cycling         | -65 °C to Timax, not to exceed 150°C                      | 1000 cycles           | 343       | 15360      | 0         |  |  |
| # A4                                                                  | remperature cycling         | os e to ijinax, not to exceed 150 e                       | 1000 Cycles           | 343       | 13300      | U         |  |  |
|                                                                       | UHAST                       | JESD22-A118                                               |                       |           |            |           |  |  |
| # A3 <b>or</b>                                                        | Unbiased HAST               | Tamb = 130 °C, RH = 85 %                                  | —96 hours             | 362       | 15920      | 0         |  |  |
|                                                                       |                             | JESD22-A102                                               |                       |           |            |           |  |  |
|                                                                       | AC                          | Tamb = 121 °C, RH = 100 %                                 |                       |           |            |           |  |  |
| # A3 alt                                                              | Autoclave                   | Pressure = 205 kPa (29.7 psia)                            |                       |           |            |           |  |  |
| r A3 dit                                                              |                             |                                                           |                       |           |            |           |  |  |
|                                                                       | H3TRB                       | JESD22-A101                                               |                       |           |            |           |  |  |
|                                                                       | High Humidity High          | Tamb = 85 °C, RH = 85%, VR = 80 % of                      |                       |           |            |           |  |  |
| # A2 alt                                                              | Temperature Reverse Bias    |                                                           | 1000 hours            | 343       | 15360      | 0         |  |  |
|                                                                       | •                           | MIL-STD-750 Method 1037                                   |                       |           |            | -         |  |  |
|                                                                       | IOL                         | ton = toff, devices powered to insure $\Delta T_j$ =      |                       |           |            |           |  |  |
| # A5                                                                  | Intermittent Operating Life |                                                           | 1000 hours            | 343       | 15360      | 0         |  |  |
|                                                                       |                             | , , , , , , , , , , , , , , , , , , ,                     | _5000010              | 2.0       |            | -         |  |  |
|                                                                       | RSH                         | JESD22-A111                                               |                       |           |            |           |  |  |
| # C8                                                                  | Resistance to Solder Heat   |                                                           | 10 s                  | 283       | 8490       | 0         |  |  |
|                                                                       | SD                          |                                                           |                       |           |            | -         |  |  |
| # C10                                                                 | Solderability               | J-STD-002                                                 |                       | 214       | 6420       | 0         |  |  |

<sup>[1]</sup> The maximum applied voltage is limited by test chamber set up and does not exceed 115V.

## **Calculation of FIT and MTTF**

Test considered for FIT calculation: High Temperature Reverse Bias (HTRB, Test #B1) Confidence level 60%, derated to 55 °C, activation energy 0.7 eV, test time 168 to 1000 hours

| Wafer Fab | Technology           | Quantity | Rejects | Failure Rate (FIT) | MTTF (hrs) |
|-----------|----------------------|----------|---------|--------------------|------------|
| Nexperia  | Small Signal Bipolar |          |         |                    |            |
| DHAM      | Transistor           | 18680    | 0       | 0,23               | 4,40E+09   |

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